

Search Notes**Application/Control No.**

10/574,816

Examiner

Taeyoon Kim

**Applicant(s)/Patent under
Reexamination**

YUGE ET AL.

Art Unit

1651

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search (EAST)	6/27/2008	TK